


<b>Search Notes</b>  	<b>Application/Control No.</b>  10816378	<b>Applicant(s)/Patent Under Reexamination</b>  LEE, CHUNG-CHIEH
	<b>Examiner</b>  Chu, Wutchung	<b>Art Unit</b>  2616

SEARCHED			
Class	Subclass	Date	Examiner
370	395.21	4/1/2004	WC
370	395.41	4/1/2004	WC
370	395.4	4/1/2004	WC
370	395.42	4/1/2004	WC
370	395.43	4/1/2004	WC
370	412	4/1/2004	WC
370	429	4/1/2004	WC
370	252	4/1/2004	WC
370	253	4/1/2004	WC
370	229	4/1/2004	WC
370	468	4/1/2004	WC

SEARCH NOTES		
Search Notes	Date	Examiner
East search	8/16/2007	WC
Inventorship search	8/16/2007	WC
Manual search for class 370/412	8/16/2007	WC
Consulted with SPE Edan Orgad	8/16/2007	WC
consulted with SPE Edan Orgad	2/6/2008	WC
updated search	2/6/2008	WC
updated search	8/21/2008	WC

INTERFERENCE SEARCH			
Class	Subclass	Date	Examiner